

SH8MA3

30V Nch+Pch Power MOSFET

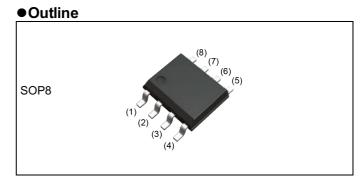
Symbol	Tr1:Nch	Tr2:Pch
V <sub>DSS</sub>	30V	-30V
R <sub>DS(on)</sub> (Max.)	28mΩ	50mΩ
Ι <sub>D</sub>	±7.0A	±6.0A
PD	2.8	3W

# Features

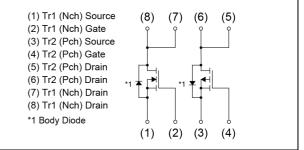
- 1) Low on resistance
- 2) Small Surface Mount Package (SOP8)
- 3) Pb-free lead plating ; RoHS compliant
- 4) Halogen Free

Application

Switching



### Inner circuit



### Packaging specifications

	Packing	Embossed Tape
	Reel size (mm)	330
Туре	Tape width (mm)	12
	Quantity (pcs)	2500
	Taping code	TB1
	Marking	SH8MA3

# • Absolute maximum ratings (T<sub>a</sub> = 25°C ,unless otherwise specified)

Deremeter	Cumph of	Va	lue	Linit
Parameter	Symbol	Tr1:Nch	Tr2:Pch	Unit
Drain - Source voltage	V <sub>DSS</sub>	30	-30	V
Continuous drain current	Ι <sub>D</sub> *1	±7.0	±6.0	А
Pulsed drain current	I_DP*2	±18	±18	А
Gate - Source voltage	V <sub>GSS</sub>	±20	±20	V
Avalanche current, single pulse	I <sub>AS</sub> *3	7.0	-6.0	А
Avalanche energy, single pulse	E <sub>AS</sub> *3	1.7	5.2	mJ
	P <sub>D</sub> <sup>*1</sup>	2	.8	
Power dissipation (total)	P <sub>D</sub> *4	2	.0	W
	P <sub>D</sub> *5	1	.4	
Junction temperature	Tj	1:	50	°C
Operating junction and storage temperature range	T <sub>stg</sub>	-55 to	+150	°C

### •Thermal resistance

Deremeter	Currence of		Values		Linit
Parameter	Symbol	Min.	Тур.	Max.	Unit
Thermal registeres innetion embient (tetal)	$R_{thJA}^{*4}$	-	-	62.5	°C/W
Thermal resistance, junction - ambient (total)	$R_{thJA}^{*5}$	-	-	89.2	C/VV

# •Electrical characteristics (T<sub>a</sub> = 25°C)

Devenueter	Or mark al	<b>T</b>	O and little and		Values		1.1:4
Parameter	Symbol	Туре	Conditions	Min.	Тур.	Max.	Unit
Drain - Source breakdown	V	Tr1	V <sub>GS</sub> = 0V, I <sub>D</sub> = 1mA	30	-	-	
voltage	V <sub>(BR)DSS</sub>	Tr2	V <sub>GS</sub> = 0V, I <sub>D</sub> = -1mA	-30	-	-	V
Breakdown voltage	ΔV <sub>(BR)DSS</sub>	Tr1	I <sub>D</sub> = 1mA, referenced to 25°C	-	21	-	
temperature coefficient	$\Delta T_j$	Tr2	$I_D = -1 \text{ mA}$ , referenced to 25°C	-	-22	-	mV/°C
Zero gate voltage		Tr1	V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V	-	-	1	
drain current	IDSS	Tr2	V <sub>DS</sub> = -30V, V <sub>GS</sub> = 0V	-	-	-1	μA
Gate - Source		Tr1	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V	-	-	±100	0
leakage current	I <sub>GSS</sub>	Tr2	V <sub>GS</sub> = -20V, V <sub>DS</sub> = 0V	-	-	±100	nA
Gate threshold	N/	Tr1	$V_{DS} = V_{GS}, I_D = 1mA$	1.0	-	2.5	V
voltage	V <sub>GS(th)</sub>	Tr2	$V_{DS} = V_{GS}, I_D = 1mA$	-1.0	-	-2.5	V
Gate threshold voltage	$\Delta V_{GS(th)}$	Tr1	I <sub>D</sub> = 1mA, referenced to 25°C	-	-3	-	mV/°C
temperature coefficient	$\Delta T_j$	Tr2	I <sub>D</sub> = -1mA, referenced to 25°C	-	2.9	-	mv/ C
		Tr1	V <sub>GS</sub> = 10V, I <sub>D</sub> = 7.0A	-	23	28	
Static drain - source	D *6	ILI	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 7.0A	-	42	57	
on - state resistance	R <sub>DS(on)</sub> *6	тО	V <sub>GS</sub> = -10V, I <sub>D</sub> = -6.0A	-	40	50	mΩ
		Tr2	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -6.0A	-	60	73	
Cata registeres	Р	Tr1		-	2.9	-	
Gate resistance	R <sub>G</sub>	Tr2	f=1MHz, open drain	-	13.5	-	Ω
Forward Transfer	IV 1*6	Tr1	V <sub>DS</sub> = 5V, I <sub>D</sub> = 7.0A	2.7	-	-	
Admittance	Y <sub>fs</sub>  * <sup>6</sup>	Tr2	V <sub>DS</sub> = -5V, I <sub>D</sub> = -6.0A	3.3	-	-	S

\*1 Pw  $\leq$  1s, Limited only by maximum temperature allowed.

\*2 Pw  $\leq$  10µs, Duty cycle  $\leq$  1%

\*3 Tr1: L  $\simeq$  0.05mH, V\_{DD} = 15V, R\_G = 25 $\Omega$ , Starting T\_j = 25 $^\circ$ C Fig.3-1,3-2

Tr2: L  $\simeq$  0.2mH, V<sub>DD</sub> = -15V, R<sub>G</sub> = 25 $\Omega$ , Starting T<sub>i</sub> = 25°C Fig.6-1,6-2

\*4 Mounted on a ceramic board (30×30×0.8mm)

\*5 Mounted on a Cu board (40×40×0.8mm)

\*6 Pulsed

# • Electrical characteristics ( $T_a = 25^{\circ}C$ )

<Tr1>

Deremeter	Sumbol	Conditions		Values		Linit
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V	-	300	-	
Output capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 15V	-	50	-	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1MHz	-	40	-	
Turn - on delay time	t <sub>d(on)</sub> *6	$V_{DD} \simeq 15$ V, $V_{GS}$ = 10V	-	7.2	-	
Rise time	t <sub>r</sub> *6	I <sub>D</sub> = 3.5A	-	8.0	-	20
Turn - off delay time	t <sub>d(off)</sub> *6	R <sub>L</sub> = 4.3Ω	-	12.0	-	ns
Fall time	t <sub>f</sub> *6	R <sub>G</sub> = 10Ω	-	5.7	-	

### <Tr2>

Deremeter	Sumbol	Conditions	,	Values		Unit
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V	-	480	-	
Output capacitance	C <sub>oss</sub>	V <sub>DS</sub> = -15V	-	85	-	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1MHz	-	65	-	
Turn - on delay time	$t_{d(on)}$ *6	$V_{DD} \simeq -15V$ , $V_{GS} = -10V$	-	8.0	-	
Rise time	t <sub>r</sub> *6	I <sub>D</sub> = -3.0A	-	12.0	-	20
Turn - off delay time	t <sub>d(off)</sub> *6	R <sub>L</sub> = 5Ω	-	40.0	-	ns
Fall time	t <sub>f</sub> *6	R <sub>G</sub> = 10Ω	-	20.0	-	



# • Gate charge characteristics ( $T_a = 25^{\circ}C$ )

# <Tr1>

Deremeter	Symbol	Conditions			Linit		
Parameter	Symbol	Symbol Conditions			Тур.	Max.	Unit
Total gata abarga	O *6		V <sub>GS</sub> = 10V	-	7.2	-	
Total gate charge	$Q_g^{*6}$	V <sub>DD</sub> ≃ 15V		-	3.7	-	5
Gate - Source charge	Q <sub>gs</sub> *6	I <sub>D</sub> = 7.0A	V <sub>GS</sub> = 4.5V	-	1.4	-	nC
Gate - Drain charge	Q <sub>gd</sub> *6			-	1.3	-	
<tr2></tr2>			-				

Parameter	Symbol		tiono	,	Linit		
	Symbol	Symbol Conditions			Тур.	Max.	Unit
Total acta charge	<b>O</b> *6		V <sub>GS</sub> = -10V	-	10.0	-	
Total gate charge	Q <sub>g</sub> *6	$V_{DD} \simeq -15V$		-	5.2	-	-0
Gate - Source charge	${\sf Q}_{\sf gs}{}^{*6}$	I <sub>D</sub> = -6.0A	V <sub>GS</sub> = -4.5V	-	1.6	-	nC
Gate - Drain charge	$Q_{gd}^{*6}$			-	1.9	-	

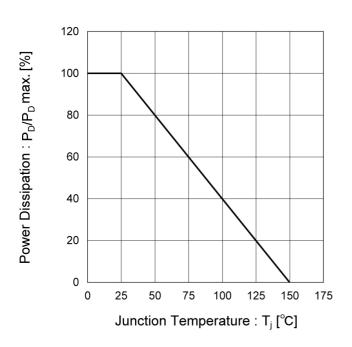
# •Body diode electrical characteristics (Source-Drain) (T<sub>a</sub> = 25°C)

<Tr1>

Parameter	Symbol	Conditions	Conditions			Unit	
Farameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Continuous forward current	۱ <sub>s</sub>	$T = 25^{\circ}$	-	-	1.67	^	
Pulse forward current	I <sub>SP</sub> *2	T <sub>a</sub> = 25°C	-	-	18	A	
Forward voltage	$V_{SD}^{*6}$	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1.67A	-	-	1.2	V	

<Tr2>

Deremeter	Symbol Conditions -		,	Unit		
Parameter			Min.	Тур.	Max.	Unit
Continuous forward current	ا <sub>s</sub>	$T = 25^{\circ}$	-	-	-1.67	^
Pulse forward current	$I_{SP}^{*2}$	T <sub>a</sub> = 25°C	-	-	-18	A
Forward voltage	$V_{SD}^{*6}$	V <sub>GS</sub> = 0V, I <sub>S</sub> = -1.67A	-	-	-1.2	V



# Fig.1 Power Dissipation Derating Curve

Fig.2 Maximum Safe Operating Area

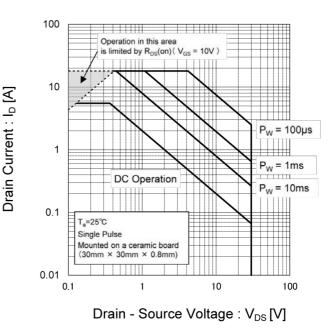
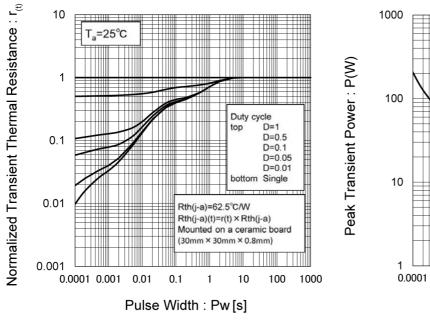
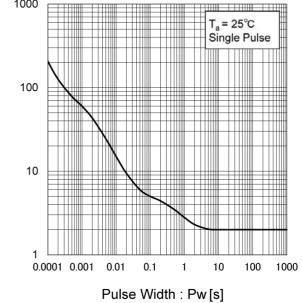


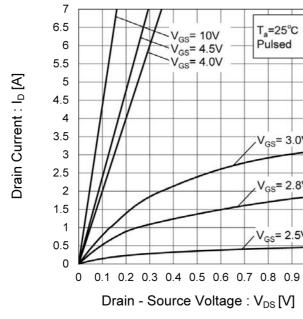
Fig.3 Normalized Transient Thermal Resistance vs. Pulse Width

Fig.4 Single Pulse Maximum Power dissipation









# Fig.5 Typical Output Characteristics(I)

T<sub>a</sub>=25°C

V<sub>GS</sub>= 3.0V

V<sub>GS</sub>= 2.8V

V<sub>GS</sub>= 2.5V

1

Pulsed

Fig.6 Typical Output Characteristics(II)

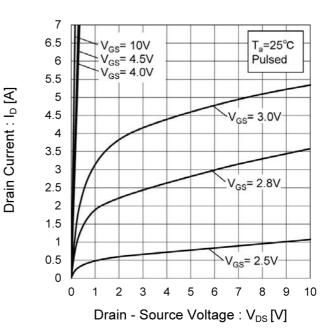
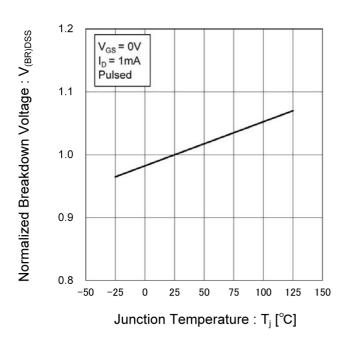
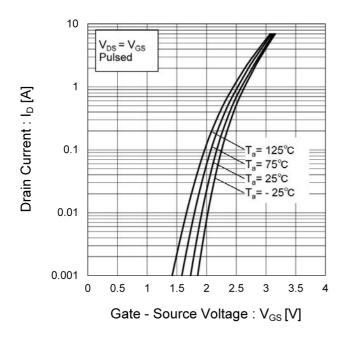


Fig.7 Breakdown Voltage vs. **Junction Temperature** 

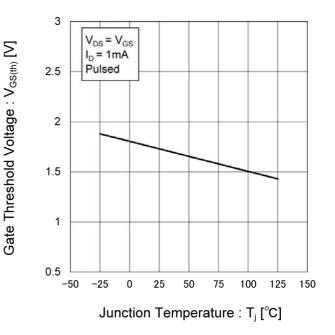




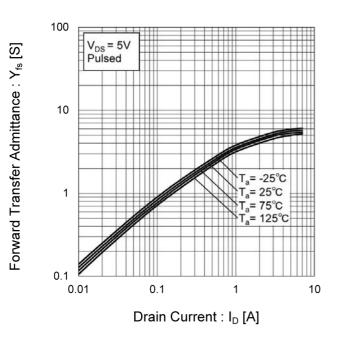


# Fig.8 Typical Transfer Characteristics

Fig.9 Gate Threshold Voltage vs. Junction Temperature



# Fig.10 Forward Transfer Admittance vs. Drain Current







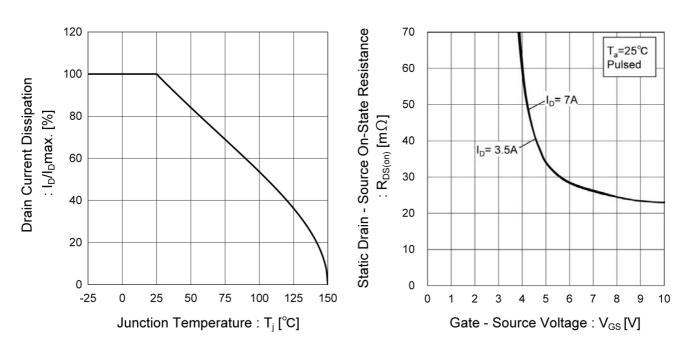


Fig.11 Drain Current Derating Curve

Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature

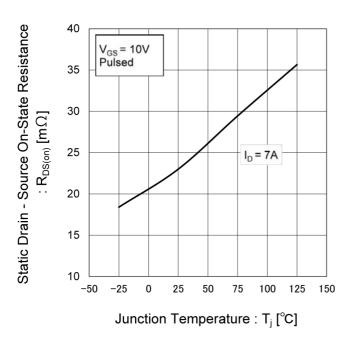






Fig.15 Static Drain - Source On - State

# •Electrical characteristic curves <Tr1>

Fig.14 Static Drain - Source On - State

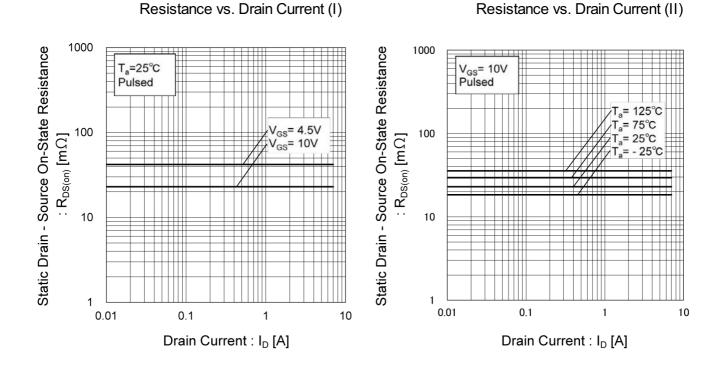


Fig.16 Static Drain - Source On - State Resistance vs. Drain Current (III)

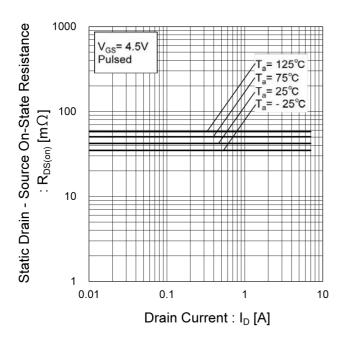
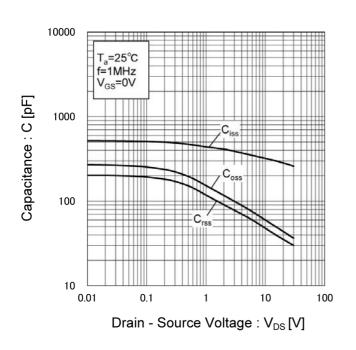




Fig.17 Typical Capacitance vs.

Drain - Source Voltage



# Fig.18 Switching Characteristics

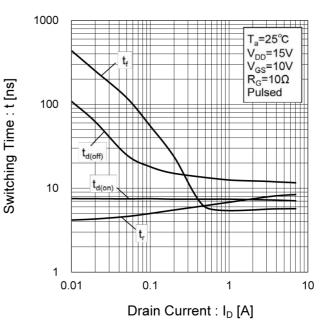


Fig.19 Dynamic Input Characteristics

Gate - Source Voltage : V<sub>GS</sub> [V]

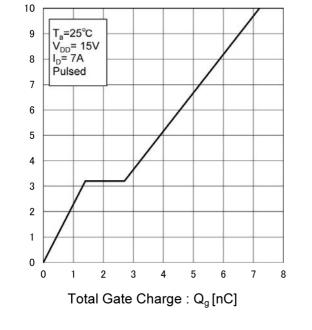
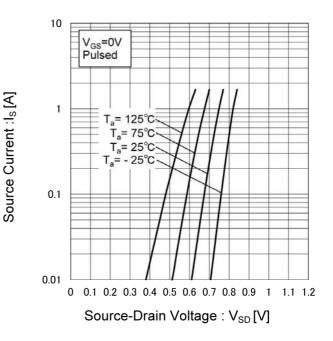
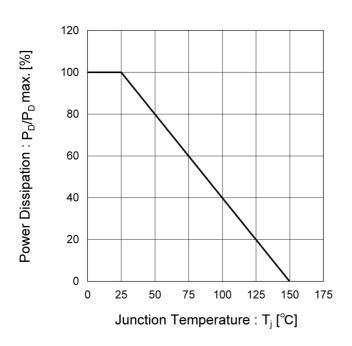


Fig.20 Source Current vs. Source Drain Voltage

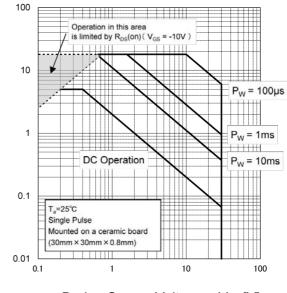






# Fig.1 Power Dissipation Derating Curve

Fig.2 Maximum Safe Operating Area



Drain Current : -I<sub>D</sub> [A]

Drain - Source Voltage : -V<sub>DS</sub> [V]

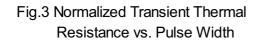
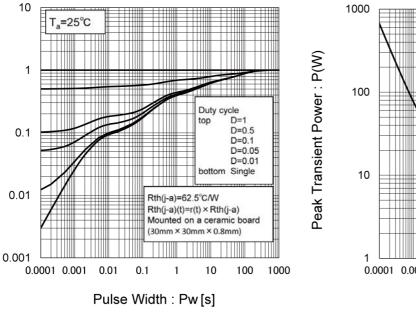
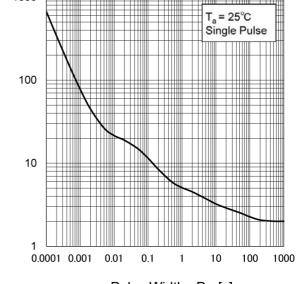


Fig.4 Single Pulse Maximum Power dissipation

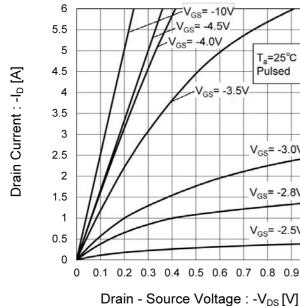




 $Pulse \ Width: Pw\,[s]$ 

Normalized Transient Thermal Resistance :  $r_{\scriptscriptstyle (t)}$ 





# Fig.5 Typical Output Characteristics(I)

V<sub>GS</sub>= -10V

<sub>GS</sub>= -4.5V

V<sub>GS</sub>= -3.5V

T<sub>a</sub>=25°C

Pulsed

V<sub>GS</sub>= -3.0V

V<sub>GS</sub>= -2.8V

V<sub>GS</sub>= -2.5V

1

V<sub>GS</sub>= -4.0V

Fig.6 Typical Output Characteristics(II)

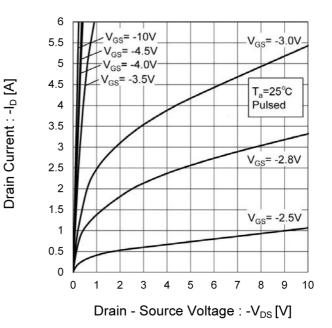
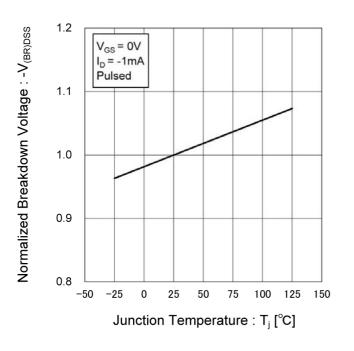
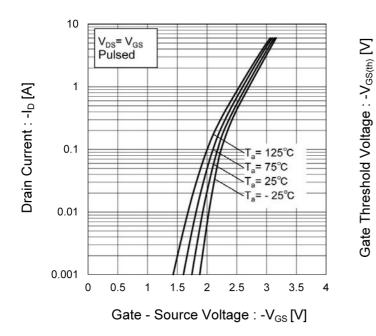


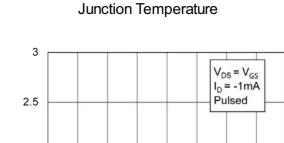
Fig.7 Breakdown Voltage vs. **Junction Temperature** 







# Fig.8 Typical Transfer Characteristics



2

1.5

1

0.5

-50

-25

0

25

Fig.9 Gate Threshold Voltage vs.

Junction Temperature : T<sub>i</sub> [°C]

50

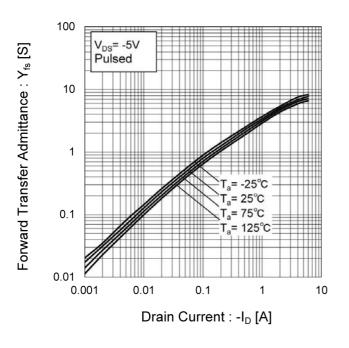
75

100

125

150

# Fig.10 Forward Transfer Admittance vs. Drain Current





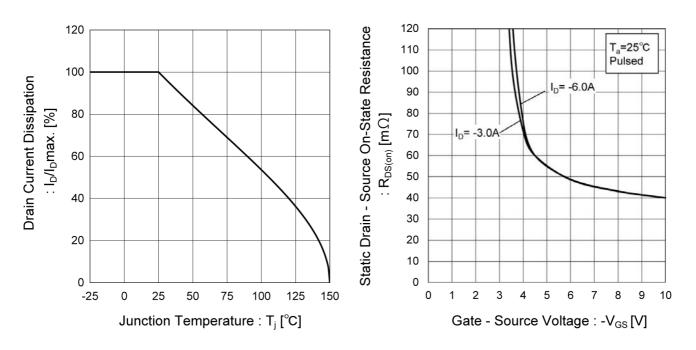
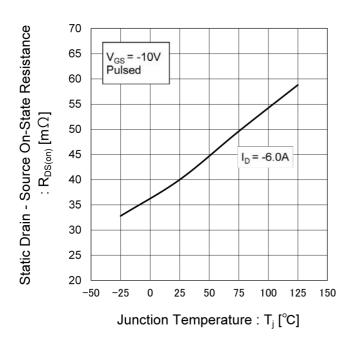


Fig.11 Drain Current Derating Curve

Fig.12 Static Drain - Source On - State Resistance vs. Gate Source Voltage

Fig.13 Static Drain - Source On - State Resistance vs. Junction Temperature





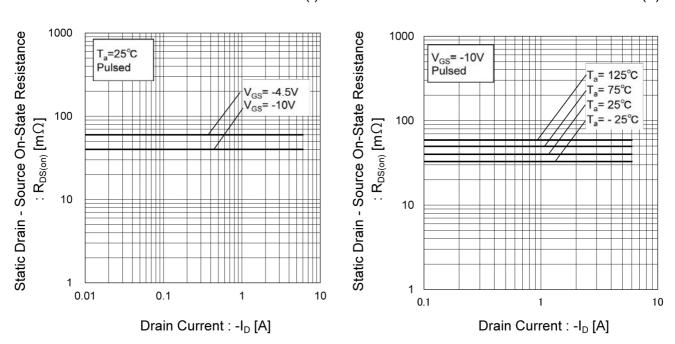


Fig.14 Static Drain - Source On - State Resistance vs. Drain Current (I) Fig.15 Static Drain - Source On - State Resistance vs. Drain Current (II)

Fig.16 Static Drain - Source On - State Resistance vs. Drain Current (III)

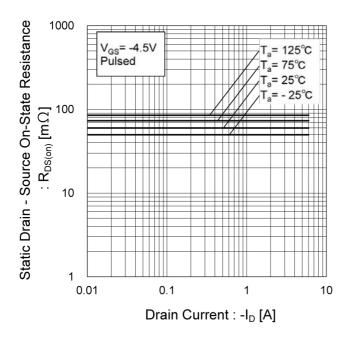
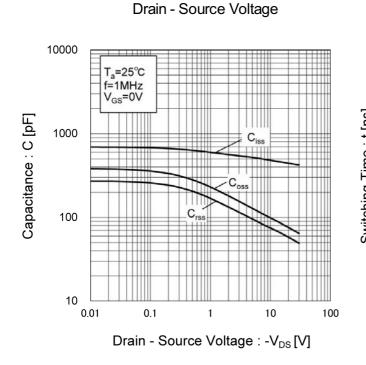




Fig.17 Typical Capacitance vs.



# Fig.18 Switching Characteristics

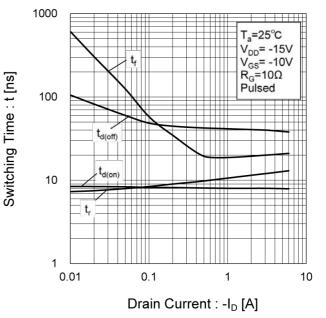


Fig.19 Dynamic Input Characteristics

Gate - Source Voltage : -V<sub>GS</sub> [V]

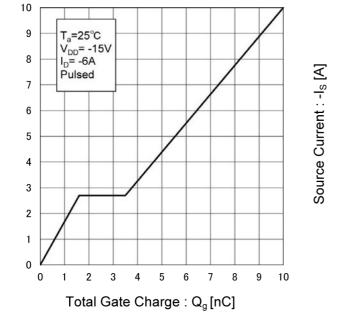
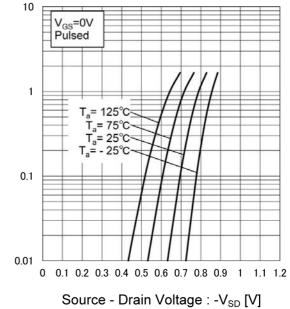


Fig.20 Source Current vs. Source Drain Voltage





# Measurement circuits <Tr1>

Fig.1-1 Switching Time Measurement Circuit

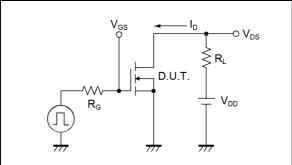


Fig.2-1 Gate Charge Measurement Circuit

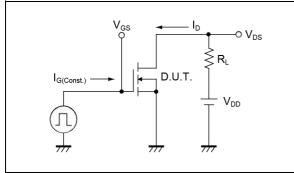


Fig.3-1 Avalanche Measurement Circuit

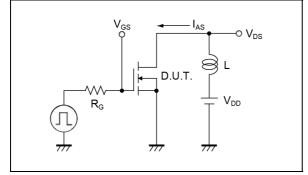


Fig.1-2 Switching Waveforms

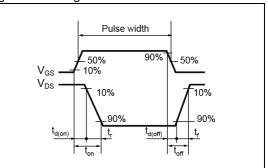
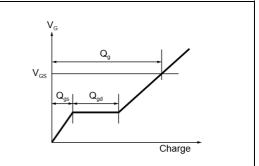
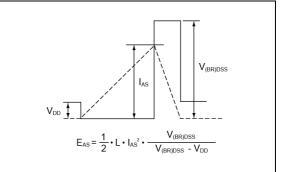


Fig.2-2 Gate Charge Waveform



### Fig.3-2 Avalanche Waveform





# Measurement circuits <Tr2>

Fig.4-1 Switching Time Measurement Circuit

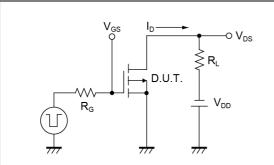


Fig.5-1 Gate Charge Measurement Circuit

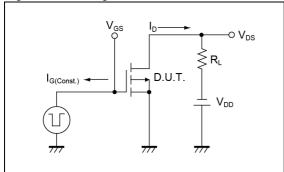


Fig.6-1 Avalanche Measurement Circuit

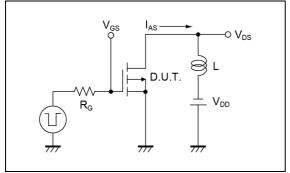
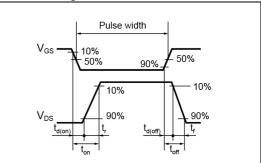
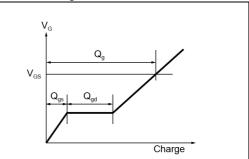


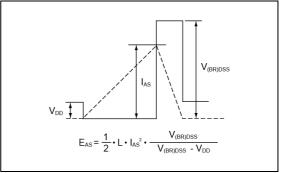
Fig.4-2 Switching Waveforms







### Fig.6-2 Avalanche Waveform

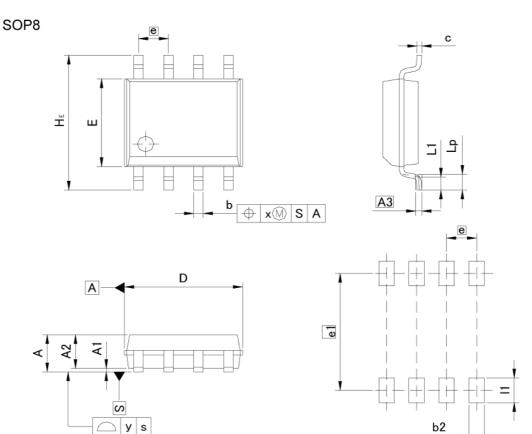


### Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.



### Dimensions



Pattern of terminal position areas [Not a pattern of soldering pads]

DIM	MILIM	ETERS	INC	HES
	MIN	MAX	MIN	MAX
A	<u>-</u> 2	1.75	-	0.069
A1	0.	15	0.0	006
A2	1.40	1.60	0.055	0.063
A3	0.	25	0.0	10
b	0.30	0.50	0.012	0.020
с	0.10	0.30	0.004	0.012
D	4.80	5.20	0.189	0.205
E	3.75	4.05	0.148	0.159
е	1.	27	0.0	50
HE	5.70	6.30	0.224	0.248
L1	0.40	0.60	0.016	0.024
Lp	0.65	0.85	0.026	0.033
x	0.	15	0.0	006
У	0.	10	0.0	04

DIM	MILIMETERS		INCHES	
	MIN	MAX	MIN	MAX
b2	<del></del>	0.65	<del></del>	0.026
e1	5.15		0.203	
11	<b>17</b> 22	1.15	<b>2</b> 76	0.045

Dimension in mm/inches



# Notice

#### Precaution on using ROHM Products

1. Our Products are designed and manufactured for application in ordinary electronic equipment (such as AV equipment, OA equipment, telecommunication equipment, home electronic appliances, amusement equipment, etc.). If you intend to use our Products in devices requiring extremely high reliability (such as medical equipment (<sup>Note 1)</sup>, transport equipment, traffic equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or failure may cause loss of human life, bodily injury or serious damage to property ("Specific Applications"), please consult with the ROHM sales representative in advance. Unless otherwise agreed in writing by ROHM in advance, ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of any ROHM's Products for Specific Applications.

(Note1) Medical Equipment Classification of the Specific Applications
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JÁPAN	USA	EU	CHINA
CLASSⅢ	CLASSⅢ	CLASS II b	CLASSⅢ
CLASSⅣ	CLASSII	CLASSⅢ	CLASSI

- 2. ROHM designs and manufactures its Products subject to strict quality control system. However, semiconductor products can fail or malfunction at a certain rate. Please be sure to implement, at your own responsibilities, adequate safety measures including but not limited to fail-safe design against the physical injury, damage to any property, which a failure or malfunction of our Products may cause. The following are examples of safety measures:
  - [a] Installation of protection circuits or other protective devices to improve system safety
  - [b] Installation of redundant circuits to reduce the impact of single or multiple circuit failure
- 3. Our Products are designed and manufactured for use under standard conditions and not under any special or extraordinary environments or conditions, as exemplified below. Accordingly, ROHM shall not be in any way responsible or liable for any damages, expenses or losses arising from the use of any ROHM's Products under any special or extraordinary environments or conditions. If you intend to use our Products under any special or extraordinary environments or conditions (as exemplified below), your independent verification and confirmation of product performance, reliability, etc, prior to use, must be necessary:
  - [a] Use of our Products in any types of liquid, including water, oils, chemicals, and organic solvents
  - [b] Use of our Products outdoors or in places where the Products are exposed to direct sunlight or dust
  - [c] Use of our Products in places where the Products are exposed to sea wind or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [d] Use of our Products in places where the Products are exposed to static electricity or electromagnetic waves
  - [e] Use of our Products in proximity to heat-producing components, plastic cords, or other flammable items
  - [f] Sealing or coating our Products with resin or other coating materials
  - [g] Use of our Products without cleaning residue of flux (Exclude cases where no-clean type fluxes is used. However, recommend sufficiently about the residue.); or Washing our Products by using water or water-soluble cleaning agents for cleaning residue after soldering
  - [h] Use of the Products in places subject to dew condensation
- 4. The Products are not subject to radiation-proof design.
- 5. Please verify and confirm characteristics of the final or mounted products in using the Products.
- 6. In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse, is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 7. De-rate Power Dissipation depending on ambient temperature. When used in sealed area, confirm that it is the use in the range that does not exceed the maximum junction temperature.
- 8. Confirm that operation temperature is within the specified range described in the product specification.
- 9. ROHM shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.

#### Precaution for Mounting / Circuit board design

- 1. When a highly active halogenous (chlorine, bromine, etc.) flux is used, the residue of flux may negatively affect product performance and reliability.
- 2. In principle, the reflow soldering method must be used on a surface-mount products, the flow soldering method must be used on a through hole mount products. If the flow soldering method is preferred on a surface-mount products, please consult with the ROHM representative in advance.

For details, please refer to ROHM Mounting specification

#### Precautions Regarding Application Examples and External Circuits

- 1. If change is made to the constant of an external circuit, please allow a sufficient margin considering variations of the characteristics of the Products and external components, including transient characteristics, as well as static characteristics.
- 2. You agree that application notes, reference designs, and associated data and information contained in this document are presented only as guidance for Products use. Therefore, in case you use such information, you are solely responsible for it and you must exercise your own independent verification and judgment in the use of such information contained in this document. ROHM shall not be in any way responsible or liable for any damages, expenses or losses incurred by you or third parties arising from the use of such information.

#### **Precaution for Electrostatic**

This Product is electrostatic sensitive product, which may be damaged due to electrostatic discharge. Please take proper caution in your manufacturing process and storage so that voltage exceeding the Products maximum rating will not be applied to Products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of lonizer, friction prevention and temperature / humidity control).

#### Precaution for Storage / Transportation

- 1. Product performance and soldered connections may deteriorate if the Products are stored in the places where:
  - [a] the Products are exposed to sea winds or corrosive gases, including Cl<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>2</sub>
  - [b] the temperature or humidity exceeds those recommended by ROHM
  - [c] the Products are exposed to direct sunshine or condensation
  - [d] the Products are exposed to high Electrostatic
- 2. Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using Products of which storage time is exceeding the recommended storage time period.
- 3. Store / transport cartons in the correct direction, which is indicated on a carton with a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- 4. Use Products within the specified time after opening a humidity barrier bag. Baking is required before using Products of which storage time is exceeding the recommended storage time period.

#### **Precaution for Product Label**

A two-dimensional barcode printed on ROHM Products label is for ROHM's internal use only.

#### Precaution for Disposition

When disposing Products please dispose them properly using an authorized industry waste company.

#### Precaution for Foreign Exchange and Foreign Trade act

Since concerned goods might be fallen under listed items of export control prescribed by Foreign exchange and Foreign trade act, please consult with ROHM in case of export.

#### **Precaution Regarding Intellectual Property Rights**

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